

OptiMOS[™]2 Small-Signal-Transistor

Features

- N-channel
- Enhancement mode
- Super Logic level (2.5V rated)
- · Avalanche rated
- Qualified according to AEC Q101
- 100% lead-free; RoHS compliant
- Halogen-free according to IEC61249-2-21

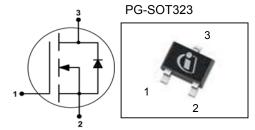






Product Summary

V_{DS}		20	V
R _{DS(on),max}	V _{GS} =4.5 V	140	mΩ
	V _{GS} =2.5 V	250	
ID		1.5	Α



Туре	Package	Tape and Reel Information	Marking	Lead Free	Packing
BSS214NW	PG-SOT323	H6327: 3000 pcs/ reel	X5s	Yes	Non dry

Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	ID	T _A =25 °C	1.5	А
		T _A =70 °C	1.2	
Pulsed drain current	I _{D,pulse}	T _A =25 °C	6	
Avalanche energy, single pulse	E _{AS}	/ _D =1.5 A, R _{GS} =25 Ω	3.7	mJ
Reverse diode dv/dt	dv/dt	/ _D =1.5 A, V _{DS} =16 V, d <i>i</i> /d <i>t</i> =200 A/μs, / _{j,max} =150 °C	6	kV/µs
Gate source voltage	V_{GS}		±12	V
Power dissipation ¹⁾	P _{tot}	T _A =25 °C	0.5	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 150	°C
ESD Class		JESD22-A114 -HBM	0 (<250V)	
Soldering Temperature			260 °C	
IEC climatic category; DIN IEC 68-1			55/150/56	



Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - ambient	$R_{ m thJA}$	minimal footprint 1)	-	-	250	K/W

Electrical characteristics, at $T_{\rm j}$ =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA	20	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	V _{DS} =0 V, I _D =3.7 μA	0.7	0.95	1.2	
Drain-source leakage current	I _{DSS}	$V_{\rm DS}$ =20 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =25 °C	1	1	1	μΑ
		V _{DS} =20 V, V _{GS} =0 V, T _j =150 °C	-	-	100	
Gate-source leakage current	I _{GSS}	V _{GS} =12 V, V _{DS} =0 V	-	-	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =2.5 V, I _D =0.7 A	-	171	250	mΩ
		V _{GS} =4.5 V, I _D =1.5 A	1	106	140	
Transconductance	$oldsymbol{g}$ fs	$ V_{\rm DS} > 2 I_{\rm D} R_{\rm DS(on)max},$ $I_{\rm D} = 1.2 \text{ A}$	-	4	-	S

 $^{^{1)}}$ Performed on $40 mm^2$ FR4 PCB. The traces are 1mm wide, $70 \mu m$ thick and 20mm long; they are present on both sides of the PCB.



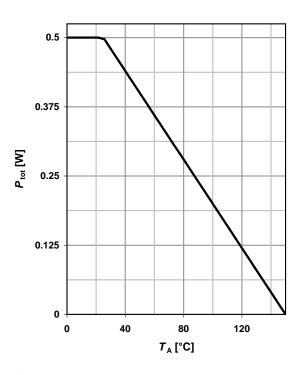
Parameter	Symbol	mbol Conditions		Values		Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	Ciss		-	107	143	pF
Output capacitance	Coss	V _{GS} =0 V, V _{DS} =10 V, f=1 MHz	-	46	62]
Reverse transfer capacitance	C _{rss}	1	-	6	-	
Turn-on delay time	$t_{d(on)}$		-	4.1	-	ns
Rise time	t _r	V _{DD} =10 V, V _{GS} =4.5 V,	-	7.8	-	
Turn-off delay time	$t_{\text{d(off)}}$	$I_{\rm D}$ =1.5 A, $R_{\rm G}$ =6 Ω	-	6.8	-	
Fall time	t_{f}		-	1.4	-	
Gate Charge Characteristics				1	Ī	
Gate to source charge	Q _{gs}]	-	0.24	-	nC
Gate to drain charge	Q_{gd}	$V_{\rm DD}$ =10 V, $I_{\rm D}$ =1.5 A, $V_{\rm GS}$ =0 to 5 V	-	0.2	-	
Gate charge total	Qg		-	0.8	-	
Gate plateau voltage	V _{plateau}		-	2.2	-	٧
Reverse Diode						
Diode continous forward current	Is	T -25 °C	-	-	0.5	Α
Diode pulse current	I _{S,pulse}	- T _A =25 °C	-	-	6	
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =1.5 A, T _j =25 °C	-	0.8	1.1	V
Reverse recovery time	t _{rr}	V_R =10 V, I_F =1.5 A, di_F/dt =100 A/ μ s	-	8.4	-	ns
Reverse recovery charge	Q _{rr}		-	1.7	-	nC

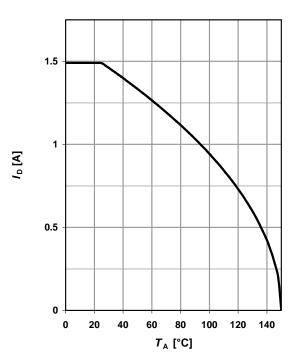


1 Power dissipation

P_{tot} =f(T_A)

2 Drain current

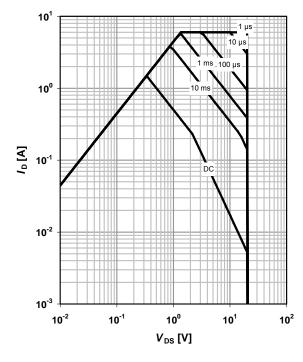




3 Safe operating area

$$I_{\rm D}$$
=f($V_{\rm DS}$); $T_{\rm A}$ =25 °C; D =0

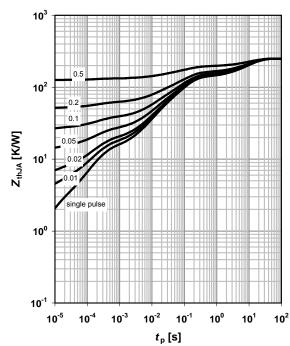
parameter: $t_{\rm p}$



4 Max. transient thermal impedance

$$Z_{\rm thJA}$$
=f($t_{\rm p}$)

parameter: $D = t_p/T$

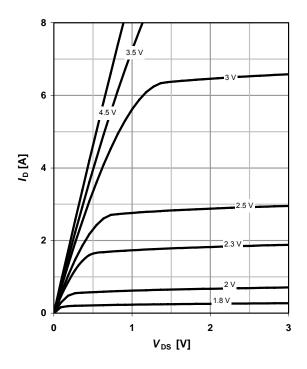




5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 °C$

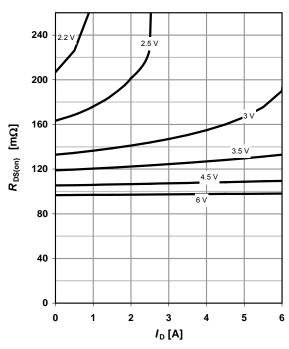
parameter: $V_{\rm GS}$



6 Typ. drain-source on resistance

 $R_{DS(on)}$ =f(I_D); T_j =25 °C

parameter: V_{GS}

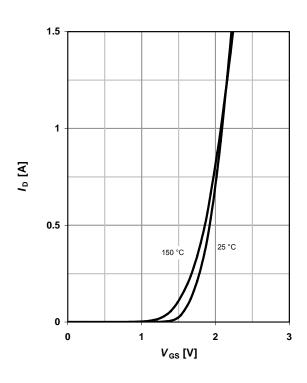


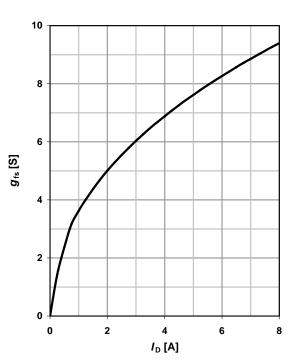
7 Typ. transfer characteristics

 I_{D} =f(V_{GS}); $|V_{DS}|$ >2 $|I_{D}|R_{DS(on)max}$



$$g_{fs}$$
=f(I_D); T_j =25 °C

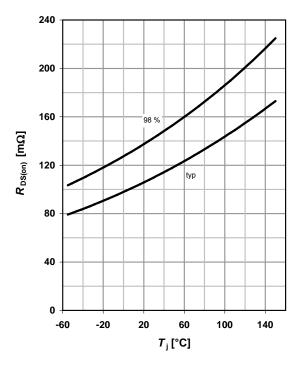






9 Drain-source on-state resistance

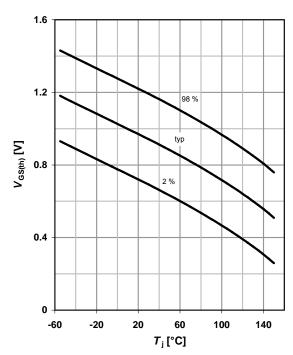
$$R_{DS(on)}$$
=f(T_j); I_D =1.5 A; V_{GS} =4.5 V



10 Typ. gate threshold voltage

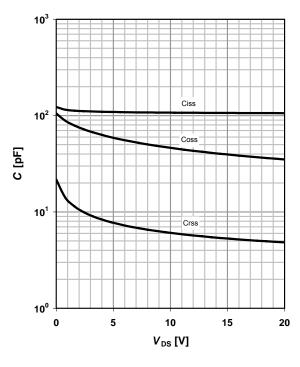
$$V_{\mathrm{GS(th)}}\!\!=\!\!\mathrm{f}(T_{\mathrm{j}});~V_{\mathrm{DS}}\!\!=\!\!V_{\mathrm{GS}};~I_{\mathrm{D}}\!\!=\!\!3.7~\mu\mathrm{A}$$

parameter: I_D



11 Typ. capacitances

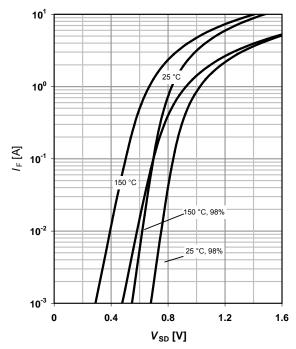
 $C=f(V_{DS}); V_{GS}=0 V; f=1 MHz; T_j=25$ °C



12 Forward characteristics of reverse diode

$$I_{\text{F}} = f(V_{\text{SD}})$$

parameter: $T_{\rm j}$





13 Avalanche characteristics

 I_{AS} =f(t_{AV}); R_{GS} =25 Ω

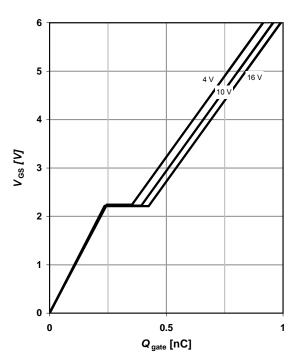
parameter: $T_{j(start)}$

10¹ 10⁰ 10¹ 10¹ 10¹ 10² 10³ t_{AV} [µs]

14 Typ. gate charge

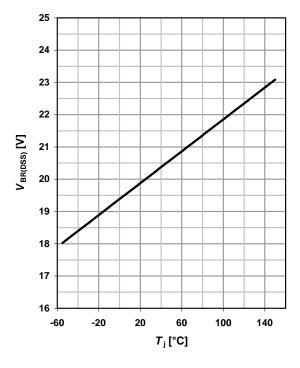
 $V_{\rm GS}$ =f($Q_{\rm gate}$); $I_{\rm D}$ =1.5 A pulsed

parameter: $V_{\rm DD}$

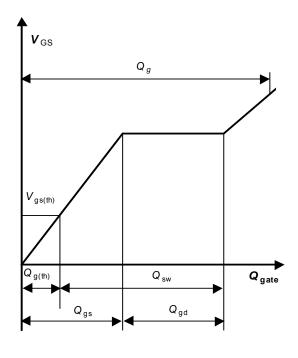


15 Drain-source breakdown voltage

 $V_{BR(DSS)}$ =f(T_i); I_D =250 μ A



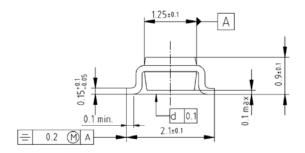
16 Gate charge waveforms

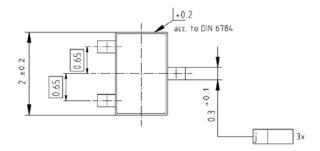




SOT323

Package Outline:



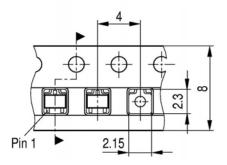


Packaging:

Footprint:

Reflow soldering Wave soldering







Dimensions in mm



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